## Application/Control No. O9/582,864 Reexamination TAKAHATA ET AL. Examiner Prasad R Akkapeddi Applicant(s)/Patent Under Reexamination TAKAHATA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,136,444	10-2000	Kon et al.	428/423.1
	В	US-			
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	К	US-			
	L	US-			
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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.